







SN74LV4053A-Q1

SCLS521D - AUGUST 2003 - REVISED JUNE 2024

SN74LV4053A-Q1 Automotive Triple 2-Channel Analog Multiplexer or Demulitplexer

1 Features

- Qualified for automotive applications
- ESD protection exceeds 2000V per MIL-STD-883, method 3015; exceeds 200V using machine model (C = 200pF, R = 0)
- 1.65V to 5.5V V_{CC} operation
- Supports mixed-mode voltage operation on all
- High on-off output-voltage ratio
- Low crosstalk between switches
- Individual switch controls
- Extremely low input current

2 Applications

- Automotive:
 - Signal gating
 - Chopping
 - Modulation or demodulation (modem)
 - Signal multiplexing for analog-to-digital and digital-to-analog conversion systems

3 Description

This triple 2-channel CMOS analog multiplexer/ demultiplexer is designed for 1.65V to 5.5V $V_{\rm CC}$ operation.

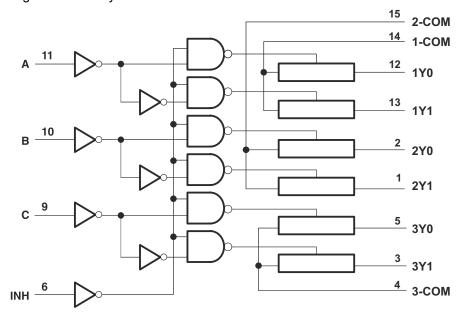
The SN74LV4053A-Q1 handles both analog and digital signals. Each channel permits signals with amplitudes up to 5.5V (peak) to be transmitted in either direction.

Applications include signal gating, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

Package Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE ⁽²⁾
SN74LV4053A-Q1	PW (TSSOP, 16)	5mm × 6.4mm

- For more information, see Section 11.
- The package size (length × width) is a nominal value and includes pins, where applicable.



Logic Diagram (Positive Logic)



Table of Contents

2 Applications 1 8 Application and Implementation 3 Description 1 8.1 Application Information 4 Pin Configuration and Functions 2 8.2 Typical Application 5 Specifications 4 8.3 Design Requirements 5.1 Absolute Maximum Ratings 4 8.4 Detailed Design Procedure 5.2 ESD Retings 4 8.5 Design Requirements	13
3 Description18.1 Application Information4 Pin Configuration and Functions28.2 Typical Application5 Specifications48.3 Design Requirements5.1 Absolute Maximum Ratings48.4 Detailed Design Procedure	
4 Pin Configuration and Functions28.2 Typical Application15 Specifications48.3 Design Requirements15.1 Absolute Maximum Ratings48.4 Detailed Design Procedure	14
5.1 Absolute Maximum Ratings4 8.4 Detailed Design Procedure	
	14
5.2 ESD Potings 4. 9.5 Dower Supply Pocommondations	14
5.2 ESD Ratings	14
5.3 Thermal Information: SN74LV4053A-Q14 8.6 Layout	14
5.4 Recommended Operating Conditions	
5.5 Electrical Characteristics	dates1 <mark>6</mark>
5.6 Timing Characteristics V _{CC} = 2.5V ± 0.2V7 9.2 Support Resources	16
5.7 Timing Characteristics V _{CC} = 3.3V ± 0.3V7 9.3 Trademarks	16
5.8 Timing Characteristics V _{CC} = 5V ± 0.5V	16
5.9 AC Characteristics	16
6 Parameter Measurement Information	16
7 Detailed Description	
7.1 Functional Block Diagram	16

4 Pin Configuration and Functions

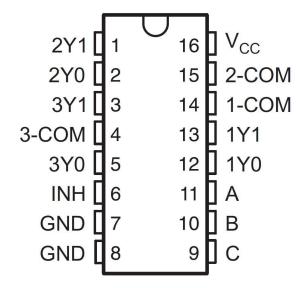


Figure 4-1. D or PW Package, 16-Pin TSSOP (Top View)

Table 4-1. Pin Functions

P	IN	T (D =(2)	DECORPTION
NAME	NO.	TYPE ⁽²⁾	DESCRIPTION
2Y1	1	J(1)	Input to mux 2
2Y0	2	J(1)	Input to mux 2
3Y1	3	J(1)	Input to mux 3
3-COM	4	O ⁽¹⁾	Output of mux 3
3Y0	5	J(1)	Input to mux 3
INH	6	I	Enables the outputs of the device. Logic low level with turn the outputs on, high level will turn them off.
GND	7	-	Ground
GND	8	-	Ground
С	9	1	Selector line for outputs (see Section 7.2 for specific information)
В	10	1	Selector line for outputs (see Section 7.2 for specific information)
Α	11	I	Selector line for outputs (see Section 7.2 for specific information)
1Y0	12	J(1)	Input to mux 1
1Y1	13	J(1)	Input to mux 1
1-COM	14	O ⁽¹⁾	Output of mux 1
2-COM	15	O ⁽¹⁾	Output of mux 2
V _{CC}	16	ı	Device power input

⁽¹⁾ These I/O descriptions represent the device when used as a multiplexer, when this device is operated as a demultiplexer pins 1Y0, 1Y1, 2Y0, 2Y1, 3Y0, 3Y1 may be considered outputs (O) and pins 1-COM, 2-COM, and 3-COM may be considered inputs (I).

⁽²⁾ I = input, O = output



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1) (3)

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	7.0	V
VI	Logic input voltage range				V
V _{IO}	Switch I/O voltage range ^{(2) (3)}		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V _I < 0	-20		mA
I _{IOK}	Switch IO diode clamp current	V _{IO} < 0 or V _{IO} > V _{CC}	-50		mA
I _T	Switch continuous current	V _{IO} = 0 to V _{CC}		±25	mA
	Continuous current through V _{CC}	ontinuous current through V _{CC} or GND		±50	mA
T _{stg}	Storage temperature		-65	150	°C

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

5.2 ESD Ratings

	V					
V _(ESD)	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 ⁽¹⁾	All pins	±2000	V	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per AEC Q100-011	All pins	±500	V	

⁽¹⁾ AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

5.3 Thermal Information: SN74LV4053A-Q1

		TMUX4053A-Q1	
	THERMAL METRIC (1)	PW (TSSOP)	UNIT
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	140.2	°C/W
R ₀ JC(top)	Junction-to-case (top) thermal resistance	72.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	98.7	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	13.4	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	97.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

Submit Document Feedback

Copyright © 2024 Texas Instruments Incorporated

⁽²⁾ Pins are diode-clamped to the power-supply rails. Over voltage signals must be voltage and current limited to maximum ratings.

⁽³⁾ This value is limited to 5.5V maximum

5.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	NOM MAX	UNIT	
V _{CC}	Supply voltage		1(2)	5.5	V	
		V _{CC} = 1.65	1.2	5.5		
		V _{CC} = 2V	1.5	5.5		
V_{IH}	High-level input voltage, logic control inputs	V_{CC} = 2.3V to 2.7V	V _{CC} x 0.7	5.5	V	
	logic control inputs	V _{CC} = 3V to 3.6V	V _{CC} x 0.7	5.5		
V _{IL}		V_{CC} = 4.5V to 5.5V	V _{CC} x 0.7	5.5		
		V _{CC} = 1.65V to 2.7V	0	0.4		
V _{IL}		V _{CC} = 1.65V to 2.7V	0	0.5		
	Low-level input voltage, logic control inputs	V _{CC} = 1.65V to 2.7V	0	V _{CC} x 0.3	V	
		V _{CC} = 3V to 3.6V	0	V _{CC} x 0.3		
		V_{CC} = 4.5V to 5.5V	0	V _{CC} x 0.3		
VI	Logic control input voltage		0	5.5	V	
V _{IO}	Switch input or output voltage	,	0	V _{CC}	V	
		V _{CC} = 1.0V to 2.0V		500		
Δt/ΔV	Logio input transition rice or fall rate	V_{CC} = 2.0V to 2.7V		200	no/\/	
ΔυΔν	Logic input transition rise or fall rate	V _{CC} = 3V to 3.6V		100	ns/V	
		V_{CC} = 4.5V to 5.5V		20		
T _A	Ambient temperature	,	-40	125	°C	

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND for proper device operation. Refer to TI application report *Implications of Slow or Floating CMOS Inputs*, SCBA004.

5.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	Condition	T _A	V _{CC}	MIN	TYP	MAX	UNIT
			25°C			60	150	
			–40°C to 85°C	1.65V			225	
			–40°C to 125°C				225	
		$V_1 = V_{00} \text{ or } (iNI)$	25°C			38	180	
	ON-state switch resistance		–40°C to 85°C	2.3V			225	Ω
-			-40°C to 125°C				225	
r _{ON}			25°C			30	150	
			–40°C to 85°C	3V			190	
			–40°C to 125°C				190	
			25°C			22	75	
			–40°C to 85°C	4.5V			100	
			–40°C to 125°C				100	

⁽²⁾ When using a V_{CC} of ≤1.2 V, it is recommended to use these devices only for transmitting digital signals. When supply voltage is near 1.2 V the analog switch ON resistance becomes very non-linear



5.5 Electrical Characteristics (continued)

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	Condition	T _A	V _{CC}	MIN	TYP	MAX	UNIT
			25°C			220	600	
			-40°C to 85°C	1.65V			700	
			-40°C to 125°C				700	
			25°C			113	500	Ω
			-40°C to 85°C	2.3V			600	
_	Peak ON-state	$I_T = 2mA$,	-40°C to 125°C				600	
r _{ON(p)}	resistance	$V_I = GND \text{ to } V_{CC},$ $V_{INH} = V_{IL}$	25°C			54	180	
			-40°C to 85°C	3V			225	
			-40°C to 125°C				225	
			25°C			31	100	
			-40°C to 85°C	4.5V			125	
			-40°C to 125°C				125	
			25°C					
			-40°C to 85°C	1.65V				
			-40°C to 85°C					
	Difference in ON- state resistance between switches		-40°C to 85°C			2.1	30	
			-40°C to 85°C	2.3V			40	Ω
۸		$I_T = 2mA$,	-40°C to 125°C				40	
∆r _{ON}		$V_I = GND \text{ to } V_{CC},$ $V_{INH} = V_{IL}$	25°C			1.4	20	
			-40°C to 85°C	3V			30	
			-40°C to 125°C				30	
			25°C			1.3	15	
			-40°C to 85°C	4.5V			20	
			-40°C to 125°C				20	
			25°C		-0.1		0.1	
I _{IH} I _{IL}	Control input current	$V_I = 5.5V$ or GND	-40°C to 85°C	0 to 5.5V	-1		1	μΑ
'IL			-40°C to 125°C		-2		2	
		V _I = V _{CC} and V _O =	25°C		-0.1		0.1	
lo/-#	OFF-state switch	GND, or V_1 = GND and V_0 =	-40°C to 85°C	5.5V	-1		1	μΑ
I _{S(off)}	leakage current	V_{CC} , $V_{INH} = V_{IH}$	-40°C to 125°C	0.00	-2		2	μπ
			25°C		-0.1		0.1	
I _{S(on)}	ON-state switch leakage current	$V_I = V_{CC}$ or GND,	-40°C to 85°C	5.5V	-1		1	μΑ
` ,	leakage current	$V_{INH} = V_{IL}$	-40°C to 125°C		-2		2	
			25°C					
Icc	Supply current	$V_I = V_{CC}$ or GND $V_{INH} = 0V$	-40°C to 85°C	5.5V			20	μΑ
		VINH - UV	-40°C to 125°C				40	
C _{IC}	Control input capacitance	f = 10MHz	25°C	3.3V		2		pF
C _{IS}	Common terminal capacitance 4053	f = 10MHz	25°C	3.3V		8.2		pF
C _{OS}	Switch terminal capacitance	f = 10MHz	25°C	3.3V		5.7		pF
C _F	Feedthrough capacitance	f = 10MHz	25°C	3.3V		0.5		pF



5.5 Electrical Characteristics (continued)

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	Condition	TA	V _{CC}	MIN	TYP N	IAX	UNIT
C _{PD}	Power dissipation capacitance 4053	C _L = 50pF, f = 10MHz	25°C	3.3V		5.3		pF

5.6 Timing Characteristics $V_{CC} = 2.5V \pm 0.2V$

	PARAMETER	FROM (INPUT)	TO (OUTPUT)	CONDITIONS	T _A	MIN	TYP	MAX	UNIT
					25°C		1.9	10	
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 15pF	–40°C to 85°C			16	ns
PHL	dolay amo				–40°C to 125°C			18	
			COM or Yn		25°C		6.6	18	
t _{PZH}	Enable delay time	INH		C _L = 15pF	–40°C to 85°C			23	ns
PZL		IIC			–40°C to 125°C			25	
	Disable delay time				25°C		7.4	18	
t _{PHZ} t _{PLZ}			COM or Yn	C _L = 15pF	–40°C to 85°C			23	- 1
					–40°C to 125°C			25	
		Propagation COM or Yn	Yn or COM	C _L = 50pF	25°C		3.8	12	
t _{PLH} t _{PHL}	Propagation delay time				–40°C to 85°C			18	ns
PHL	delay time				–40°C to 125°C			20	
					25°C		7.8	28	
t _{PZH}	Enable delay time	INH	COM or Yn	C _L = 50pF	–40°C to 85°C			35	ns
t _{PZL}	unic				–40°C to 125°C			35	1
					25°C		11.5	28	
t _{PHZ}	Disable delay	Disable delay ime $COM \text{ or Yn}$ $C_L = 50$	C _L = 50pF	–40°C to 85°C			35	ns	
t _{PLZ}	ume			-40°C to 125°C			35		

5.7 Timing Characteristics $V_{CC} = 3.3V \pm 0.3V$

P/	ARAMETER	FROM (INPUT)	TO (OUTPUT)	CONDITIONS	T _A	MIN	TYP	MAX	UNIT
					25°C		2.5	9	
t _{PLH} t _{PHL}	Propagation delay time	COM or Yn	Yn or COM	C _L = 50pF	–40°C to 85°C			12	ns
PHL	asiay amis	aciay time			-40°C to 125°C			14	
	Enable delay	Enable delay INH C	COM or Yn	C _L = 50pF	25°C		5.5	20	
t _{PZH}					–40°C to 85°C			25	ns
PZL					-40°C to 125°C			25	
					25°C		8.8	20	
t _{PHZ}	Disable delay time	' IINH ICOMOTYN	C _L = 50pF	–40°C to 85°C			25	ns	
PLZ					-40°C to 125°C			25	

5.8 Timing Characteristics V_{CC} = 5V ± 0.5V

ı	PARAMETER FROM		TO (OUTPUT)	CONDITIONS	T _A	MIN	TYP	MAX	UNIT
					25°C		1.5	6	
t _{PLH}	Propagation delay time	COM or Yn	Yn or COM		–40°C to 85°C			8	ns
THE	25.27				–40°C to 125°C			10	



5.8 Timing Characteristics $V_{CC} = 5V \pm 0.5V$ (continued)

PA	PARAMETER FROM (INPU		TO (OUTPUT)	CONDITIONS	T _A	MIN	TYP	MAX	UNIT
					25°C		4	14	
t _{PZL} Enable delay time	INH	COM or Yn	C _L = 50pF	–40°C to 85°C			18	ns	
					-40°C to 125°C			18	
		y INH	COM or Yn		25°C		6.2	14	
t _{PHZ} t _{PLZ}	Disable delay time			C _L = 50pF	–40°C to 85°C			18	ns
PLZ					-40°C to 125°C			18	

5.9 AC Characteristics

PARAMETER	FROM (INPUT)	TO (OUTPUT)	Device	CONDIT	TIONS	MIN TYP	MAX	UNIT
Frequency					V _{CC} = 2.3V	30		
response (switch	COM or Yn	Yn or COM	SN74LV4053	$ 600\Omega$, $ F_{in} = 1$ MHz (sine	V _{CC} = 3V	35		MHz
on)				wave),	V _{CC} = 4.5V	50		
Feedthrough					V _{CC} = 2.3V	-45		
attenuation	COM or Yn	Yn or COM	ALL	$600Ω$, $F_{in} = 1MHz$ (sine	V _{CC} = 3V	-45		dB
(switch off)				wave)	V _{CC} = 4.5V	-45		
Crosstalk	COM or Yn			C _L = 50pF, R _L =	V _{CC} = 2.3V	20		
(between any		Yn or COM	ALL	$ 600\Omega$, $ F_{in} = 1$ MHz (sine	V _{CC} = 3V	35		mV
switches)				wave)	V _{CC} = 4.5V	60		
				C _L = 50pF, R _L =	$V_{I} = 2V_{p-p}$ $V_{CC} = 2.3V$	0.1		
Sine-wave distortion	COM or Yn	Yn or COM	ALL	10kΩ, $F_{in} = 1kHz$ (sine	$V_{I} = 2.5V_{p-p}$ $V_{CC} = 3V$	0.1		%
				wave)	$V_{I} = 4V_{p-p}$ $V_{CC} = 4.5V$	0.1		

Product Folder Links: SN74LV4053A-Q1



6 Parameter Measurement Information

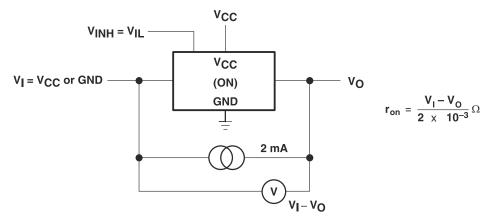
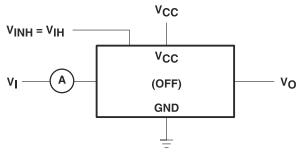


Figure 6-1. On-State Resistance Test Circuit



Condition 1: $V_I = 0$, $V_O = V_{CC}$ Condition 2: $V_I = V_{CC}$, $V_O = 0$

Figure 6-2. Off-State Switch Leakage-Current Test Circuit

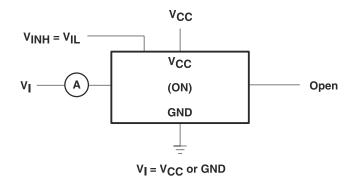


Figure 6-3. On-State Switch Leakage-Current Test Circuit



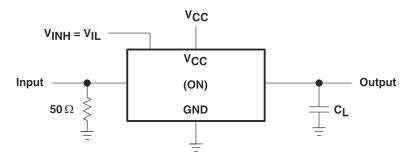


Figure 6-4. Propagation Delay Time, Signal Input to Signal Output

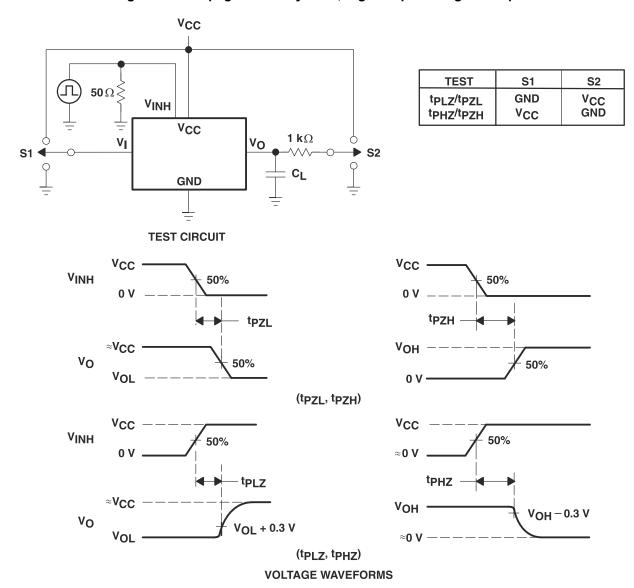
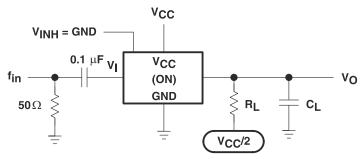


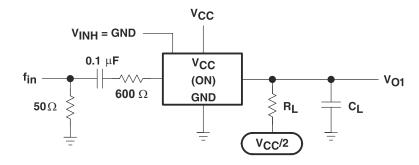
Figure 6-5. Switching Time (t_{PZL}, t_{PLZ}, t_{PZH}, t_{PHZ}), Control to Signal Output





NOTE A: fin is a sine wave.

Figure 6-6. Frequency Response (Switch On)



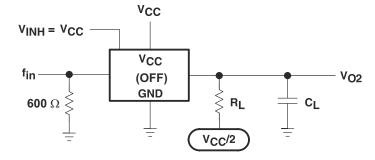


Figure 6-7. Crosstalk Between Any Two Switches

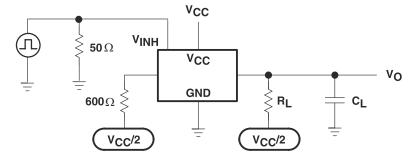


Figure 6-8. Crosstalk Between Control Input and Switch Output



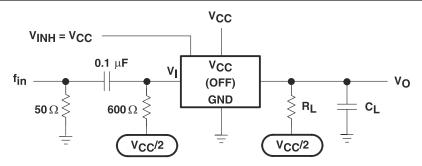


Figure 6-9. Feedthrough Attenuation (Switch Off)

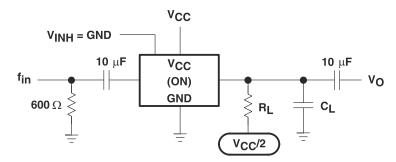
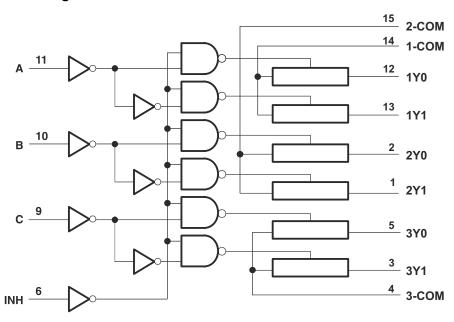


Figure 6-10. Sine-Wave Distortion



7 Detailed Description

7.1 Functional Block Diagram



7.2 Device Functional Modes

Function Table

	ll.	ON					
INH	С	В	Α	CHANNEL			
L	L	L	L	1Y0, 2Y0, 3Y0			
L	L	L	Н	1Y1, 2Y0, 3Y0			
L	L	Н	L	1Y0, 2Y1, 3Y0			
L	L	Н	Н	1Y1, 2Y1, 3Y0			
L	Н	L	L	1Y0, 2Y0, 3Y1			
L	Н	L	Н	1Y1, 2Y0, 3Y1			
L	Н	Н	L	1Y0, 2Y1, 3Y1			
L	Н	Н	Н	1Y1, 2Y1, 3Y1			
Н	X	Х	Χ	None			

8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

A multiplexer is used in applications where multiple signals share a resource. In the following example, several different sensors are connected to the analog-to-digital converter (ADC) of a microcontroller (MCU).

8.2 Typical Application

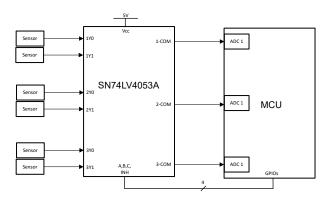


Figure 8-1. Typical Application Schematic

8.3 Design Requirements

Processing 8 different analog signals would normally require 8 separate ADCs, but the previous figure shows how to achieve this using only 2 ADCs and 3 GPIOs (general purpose input/outputs).

8.4 Detailed Design Procedure

To design with the SN74LV4053A-Q1, a stable input voltage between 2V (see *Recommended Operating Conditions* for details) and 5.5V must be available. The characteristics of the signal that is being multiplexed so that no important information is lost due to timing or voltage level incompatibility with this device is another important design consideration.

8.5 Power Supply Recommendations

Most systems have a common 3.3V or 5V rail that may be used to supply the V_{CC} pin of this device. If this is not available, then a Switch-Mode-Power-Supply (SMPS) or a Linear Dropout Regulator (LDO) may be used to supply this device from a higher voltage rail.

8.6 Layout

8.6.1 Layout Guidelines

In general, it is best to keep signal lines as short and as straight as possible. Incorporation of microstrip or stripline techniques is also recommended when signal lines are greater than 1 inch in length. These traces must be designed with a characteristic impedance of either 50Ω or 75Ω , as required by the application. Be careful placing this device too close to high voltage switching components, as they may cause interference.

Product Folder Links: SN74LV4053A-Q1



8.6.2 Layout Example

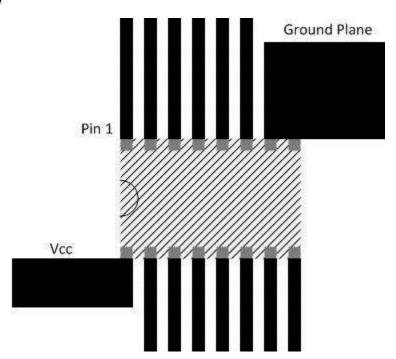


Figure 8-2. Layout Example Schematic



9 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.3 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision C (June 2011) to Revision D (June 2024)	Page
•	Changed the numbering format for tables, figures, and cross-references throughout the document	1
•	Added new VIH and VIL Specifications at 1.65V Vcc	5
•	Added Ron, Ron Peak, and Delta Ron Specifications at 1.65V Vcc	5
	· · · · · · · · · · · · · · · · · · ·	

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: SN74LV4053A-Q1



www.ti.com 25-Jun-2024

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LV4053AQPWRQ1	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	4053AQ1	Samples
SN74LV4053ATDRQ1	NRND	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 105	L4053AQ	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE OPTION ADDENDUM

www.ti.com 25-Jun-2024

OTHER QUALIFIED VERSIONS OF SN74LV4053A-Q1:

● Catalog : SN74LV4053A

● Enhanced Product : SN74LV4053A-EP

NOTE: Qualified Version Definitions:

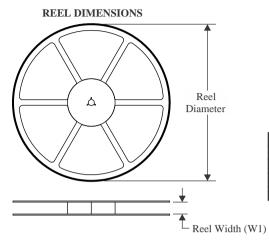
• Catalog - TI's standard catalog product

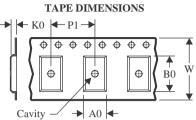
• Enhanced Product - Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

www.ti.com 17-Aug-2023

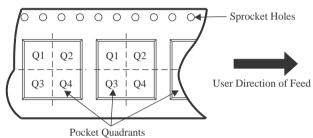
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

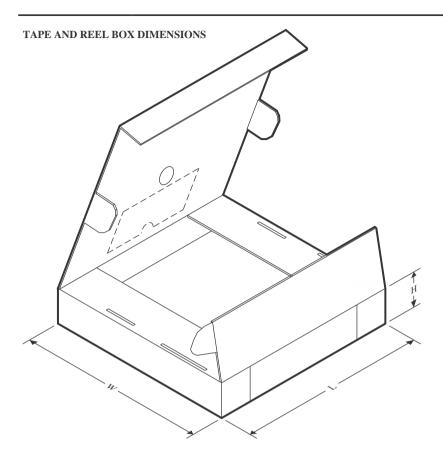


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CLV4053ATPWRG4Q1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV4053AQPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV4053ATPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



www.ti.com 17-Aug-2023



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CLV4053ATPWRG4Q1	TSSOP	PW	16	2000	367.0	367.0	35.0
SN74LV4053AQPWRQ1	TSSOP	PW	16	2000	356.0	356.0	35.0
SN74LV4053ATPWRQ1	TSSOP	PW	16	2000	356.0	356.0	35.0

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated